

RoHS COMPLIANT

## **AON6704A-VB Datasheet** N-Channel 30 V (D-S) MOSFET

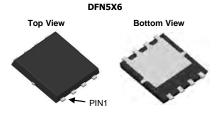
PRODUCT SUMMARY						
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>a, e</sup>	Q <sub>g</sub> (Typ.)			
30	0.003 at V <sub>GS</sub> = 10 V	120	71 nC			
	0.005 at V <sub>GS</sub> = 4.5 V	90	7110			

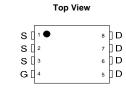
### **FEATURES**

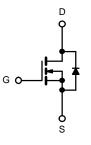
- Trench Power MOSFET
- ٠ 100 % R<sub>g</sub> and UIS Tested

#### **APPLICATIONS**

- Notebook PC Core
- VRM/POL •







N-Channel MOSFET

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	30	V	
Gate-Source Voltage	V <sub>GS</sub>	± 20	v	
	T <sub>C</sub> = 25 °C		120 <sup>a, e</sup>	
Continuous Drain Current (T <sub>J</sub> = 175 °C)	T <sub>C</sub> = 70 °C		90 <sup>e</sup>	
Continuous Drain Current $(1) = 175$ C)	T <sub>A</sub> = 25 °C	. I <sub>D</sub>	21 <sup>b, c</sup>	A
	T <sub>A</sub> = 70 °C		20.8 <sup>b, c</sup>	
Pulsed Drain Current	I <sub>DM</sub>	250		
Avalanche Current Pulse	L = 0.1 mH	I <sub>AS</sub>	56	
Single Pulse Avalanche Energy		E <sub>AS</sub>	60	mJ
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	I <sub>S</sub>	80 <sup>a, e</sup>	Α
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C		76 <sup>b, c</sup>	
	T <sub>C</sub> = 25 °C		210 <sup>a</sup>	
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	155	w
Maximum Power Dissipation	T <sub>A</sub> = 25 °C		35 <sup>b, c</sup>	vv
	T <sub>A</sub> = 70 °C	[	13 <sup>b, c</sup>	
Operating Junction and Storage Temperature R	ange	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 175	°C

THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient <sup>b, d</sup>	$t \le 10 \text{ s}$	R <sub>thJA</sub>	41	50	°C/W		
Maximum Junction-to-Case	Steady State	R <sub>thJC</sub>	0.7	0.9			

Notes:

a. Based on  $T_C = 25 \text{ °C}$ . b. Surface mounted on 1" x 1" FR4 board.

c. t = 10 s.

d. Maximum under steady state conditions is 90 °C/W.
e. Calculated based on maximum junction temperature. Package limitation current is 80 A.

<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 °C, unless otherwise noted)								
Parameter	Symbol	Test Conditions	Min .	Тур.	Max.	Unit		
Static			1		1			
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 V, I_D = 250 \mu A$	30			V		
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 250 μA		35		mV/°C		
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	_		- 5.5				
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$	1.0		2.5	V		
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V$ , $V_{GS} = \pm 20 V$			± 100	nA		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$			1	μA		
Zero Gale voltage Drain Gurrent	'DSS	$V_{DS} = 30$ V, $V_{GS} = 0$ V, $T_{J} = 55$ °C			10			
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	80			А		
Durin Course On State Desistance?	Provide	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 32 A		0.003		Ω		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 29 A		0.005				
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 32 A		130		S		
Dynamic <sup>b</sup>								
Input Capacitance	C <sub>iss</sub>				3200	pF		
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 12.5 V, V <sub>GS</sub> = 0 V, f = 1 MHz			1025			
Reverse Transfer Capacitance	C <sub>rss</sub>				970			
Table Oats Observe	Qg	$V_{DS} = 15 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 32 \text{ A}$			71	nC		
Total Gate Charge					61.5			
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS}$ = 15 V, $V_{GS}$ = 4.5 V, $I_{D}$ = 29 A			34			
Gate-Drain Charge	Q <sub>gd</sub>				29			
Gate Resistance	Rg	f = 1 MHz		1.4	2.1	Ω		
Turn-On Delay Time	t <sub>d(on)</sub>			18	27			
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_L$ = 0.555 $\Omega$		11	17	- ns		
Turn-Off Delay Time	t <sub>d(off)</sub>	$\text{I}_\text{D}{\cong}27$ A, $\text{V}_\text{GEN}$ = 10 V, R_g = 1 $\Omega$		70	105			
Fall Time	t <sub>f</sub>			10	15			
Turn-On Delay Time	t <sub>d(on)</sub>			55	83			
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_{L}$ = 0.625 $\Omega$		180	270			
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 24$ A, $V_{GEN} = 4.5$ V, $R_g = 1 \Omega$		55	83			
Fall Time	t <sub>f</sub>			12	18			
Drain-Source Body Diode Characteristic								
Continuous Source-Drain Diode Current	۱ <sub>S</sub>	T <sub>C</sub> = 25 °C			80			
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				100	A		
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 22 A		0.8	1.2	V		
Body Diode Reverse Recovery Time	t <sub>rr</sub>			52	78	ns		
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			70.2	105	nC		
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 20 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$		27				
Reverse Recovery Rise Time t <sub>b</sub>				25		ns		

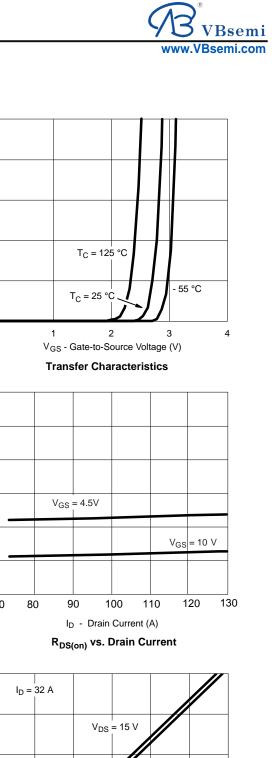
Notes:

a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %.

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

3.0

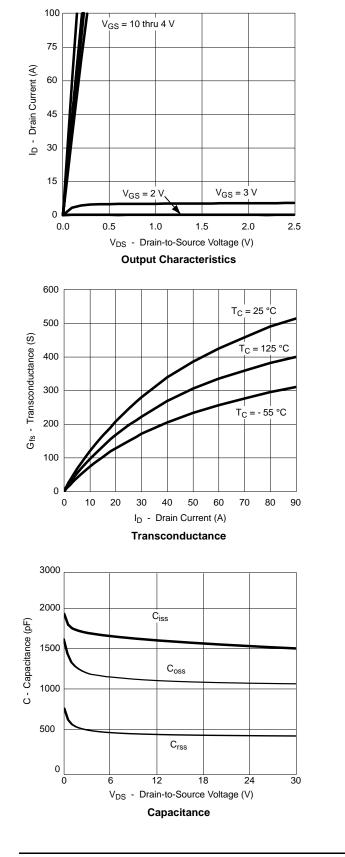
2.4

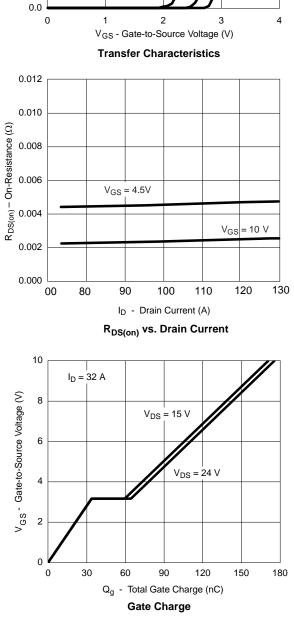
1.8

1.2

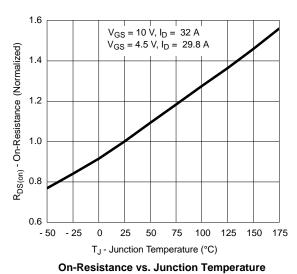
0.6

I<sub>D</sub> - Drain Current (A)

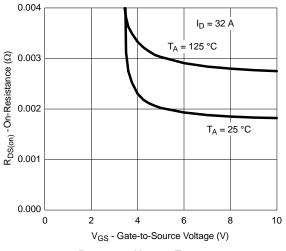




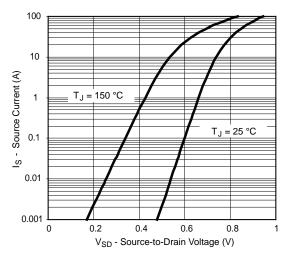




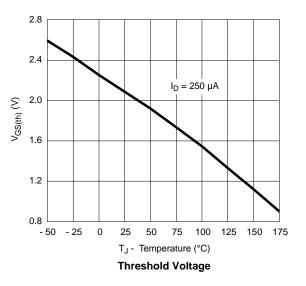
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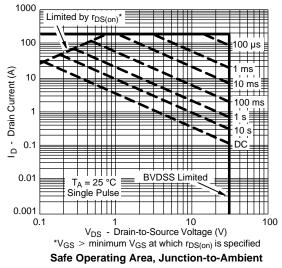


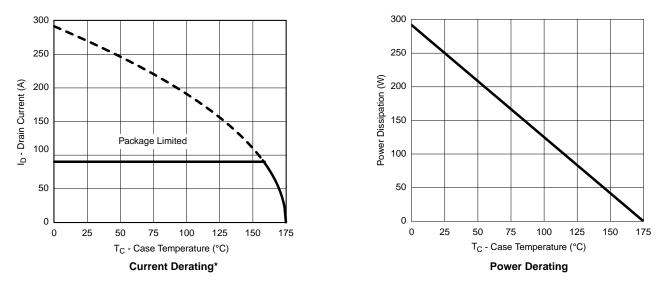
 $R_{\text{DS(on)}}$  vs.  $V_{\text{GS}}$  vs. Temperature



Forward Diode Voltage vs. Temperature

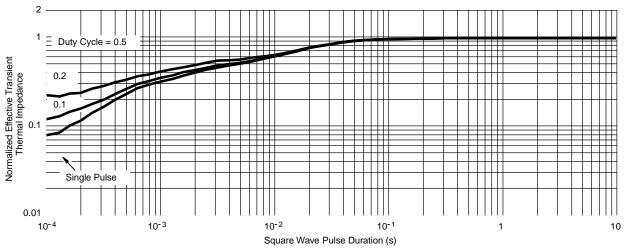




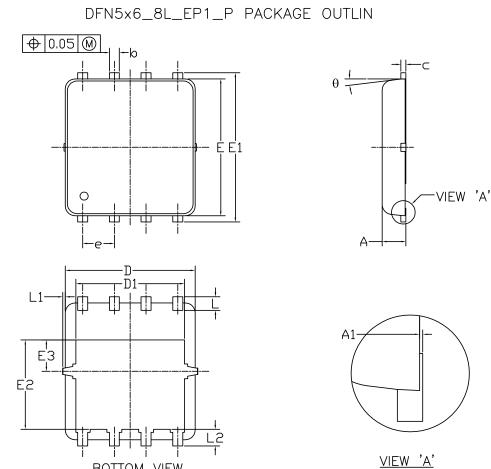


#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

\* The power dissipation  $P_D$  is based on  $T_{J(max)} = 175$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



Normalized Thermal Transient Impedance, Junction-to-Case



BOTTOM VIEW



RECOMMENDED LAND PATTERN .60 r0.55 0.50 -0.77 -0.635 4.12 6.15 T 1.60 +  $\left|+\right|$ + 0.65 +t. -11.27-0.50-

SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES			
STNBOLS	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.85	0.95	1.00	0.033	0.037	0.039	
Al	0.00		0.05	0.000		0.002	
b	0.30	0.40	0.50	0.012	0.016	0.020	
c	0.15	0.20	0.25	0.006	0.008	0.010	
D	5.10	5.20	5.30	0.201	0.205	0.209	
D1	4.25	4.35	4.45		0.171		
Е		5.55			0.219		
E1		6.05			0.238		
E2		3.625			0.143		
E3		1.275			0.050		
e	1.27 BSC			0.050 BSC			
L	0.45	0.55	0.65	0.018	0.022	0.026	
L1	0		0.15	0		0.006	
L2	0.68 REF			0.027 REF			
θ	0°		10°	0°		10°	

#### NOTE

UNIT: mm

1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS. MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.

2. CONTROLLING DIMENSION IS MILLIMETER.

CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.



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